

Tag & Probe Muon Efficiency Measurements For Higgs analysis At 13TeV

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WP1---EENP2 Meeting

outlines



- ∞ Introduction.
- ∞ Datasets.
- ∞ The Selections for Tag & Probe muon.
 - For the Reconstruction and ID efficiencies.
 - For the Isolation efficiencies.
- ∞ The Reconstruction for TP Pairs.
- ∞ Results for Isolation efficiencies.
- ∞ Results for Reconstruction and ID efficiencies.
 - Loose ID.
 - Tight ID.
- ∞ Conclusion.

Tag & probe

□ The Tag and Probe Tool is a generic tool developed to measure any user defined object efficiency from data or MC at CMS by exploiting di-object resonances like Z or J/Psi.

- resonances are reconstructed as pairs with one leg passing a tight identification (**tag**) and one passing a loose identification (**probe**).
- "**passing probes**" are defined according to whatever is the efficiency to measure.
- the (**tag + passing probe**) and (**tag + failing probe**) line shapes are fit separately with a signal + background model, then the efficiency is computed from the ratio of the signal yields.

□ In this work muon efficiencies are measured with the Tag and Probe (T&P) method performed on $Z \rightarrow \mu\mu$ events in bins of p_T and $|\eta|$.

Details on samples

Data:

- Collision data at 13 TeV and 25 ns bunch spacing.
- Single Muon dataset.
- Run D Integrated luminosity 2.25/fb.
- Run C Integrated luminosity 17.2 /pb.
- The JSON file: Cert_13TeV_16Dec2015ReReco_Collisions15_25ns_JSON.txt.

•/SingleMuon/Run2015D-16Dec2015-v1/AOD

•/SingleMuon/Run2015C_25ns-16Dec2015-v1/AOD

MC:

- Drell-Yan + Jets sample generated with MadGraph_aMC@NLO

•/DYJetsToLL_M-50_TuneCUETP8M1_13TeV-madgraphMLM-pythia8/RunIIFall15DR76-PU25nsData2015v1_76X_mcRun2_asymptotic_v12-v1/AODSIM/

Muon Reconstruction and Identification

Efficiencies are computed for the following ID criteria:

❑ Loose Muon ID:

- $PT > 5 \text{ GeV} \ \& \ |\eta| < 2.4$
- `isGlobalMuon || (isTrackerMuon && numberOfMatches>0)`
- $dxy < 0.5, \ dz < 1.$
- Standalone Muon tracks that are only reconstructed in the muon system are rejected (`muonBestTrackType !=2`).

❑ Tight muons ID:

defined as loose muons that are also PF muons.

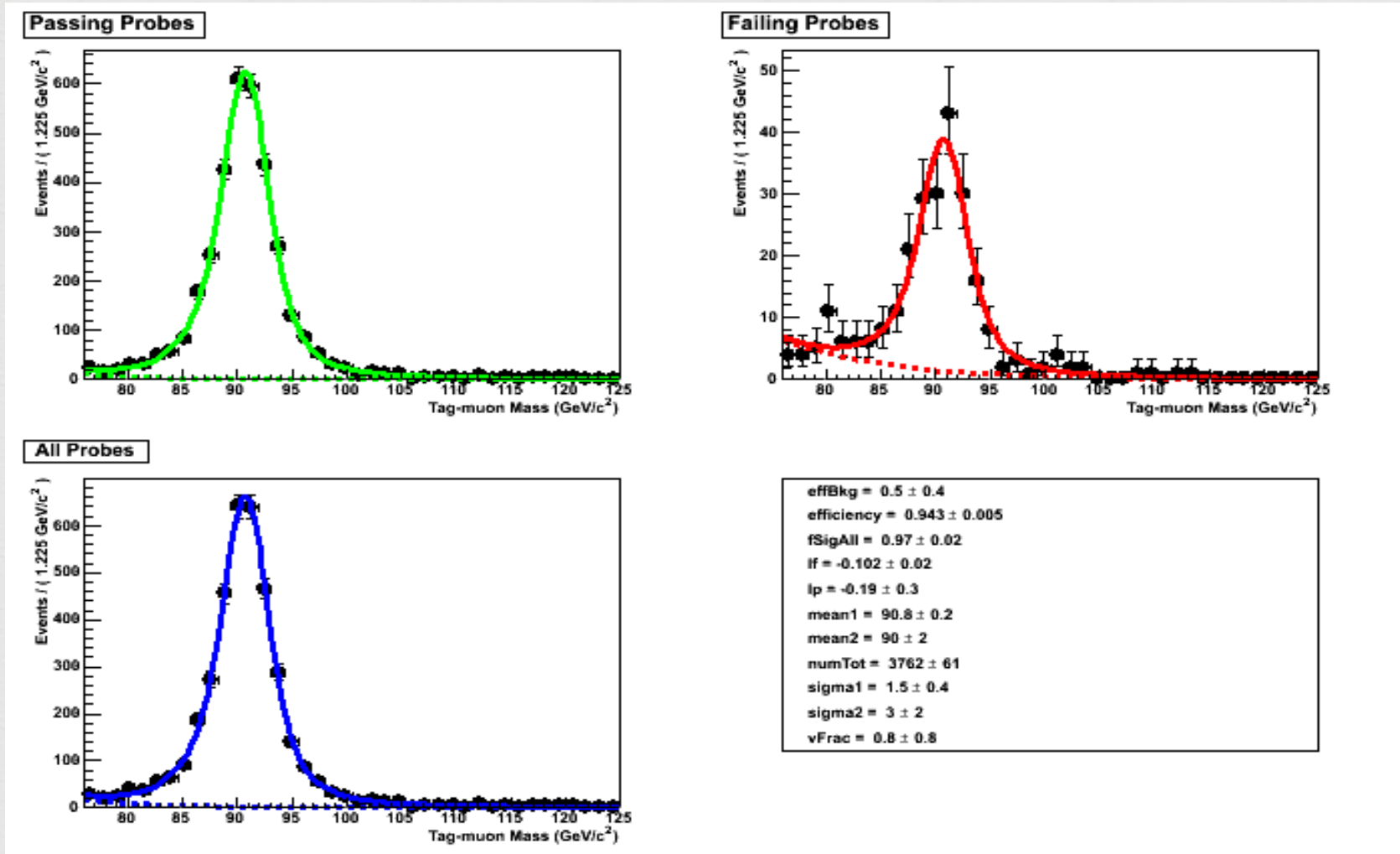
The Selection for Tag & Probe muon

- ❑ **The tag muon** is reconstructed according to the “**Tight muon ID**” as defined by muon POG.
- ❑ The Tag muon $PT > 25 \text{ GeV}$ & $|\eta| < 2.1$
- ❑ Geometrically matched to the leg of single muon trigger object.
“the trigger path **HLT_IsoMu20**”
- ❑ Geometrically matched to the leg of generator level object i.e. MC truth matching.
- ❑ **The probe muon for ID eff:** ($PT > 3 \text{ GeV}$ & $|\eta| < 2.5$ & track .isNonnull).
- ❑ **The probe muon for ISO eff:** are muons passing tight ID requirements.

The Reconstruction for TP Pairs

- ❑ The tag and probe muons must be oppositely charged to avoid a double choice of tags (TT pair).
- ❑ Mass of $t\bar{p}$ pair is $60 < m(\mu\mu) < 120$ GeV.
- ❑ δz between tag and probe muon $|\delta z| < 1$.

Example of di-muon invariant mass distributions obtained in the tag-and-probe measurements of the muon reconstruction/identification efficiency



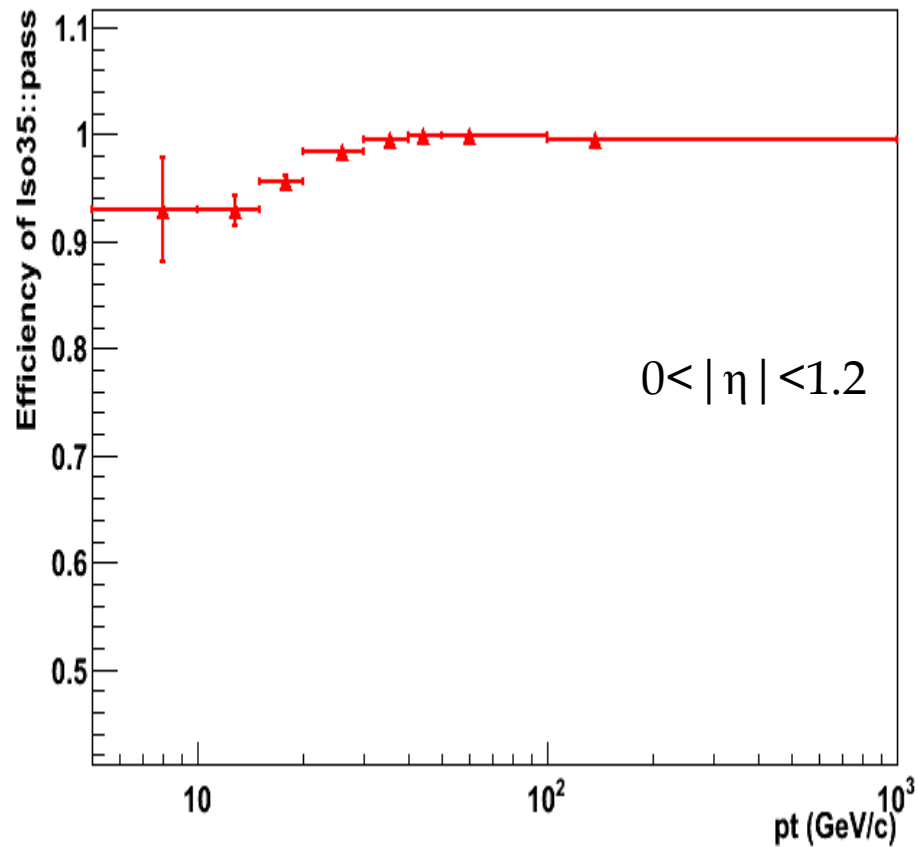
Efficiency of tight ID muons passing isolation.

□ Particle-flow relative isolation in a $\Delta R = 0.3$ cone with delta Beta correction (**PF Iso Tight < 0.35**).

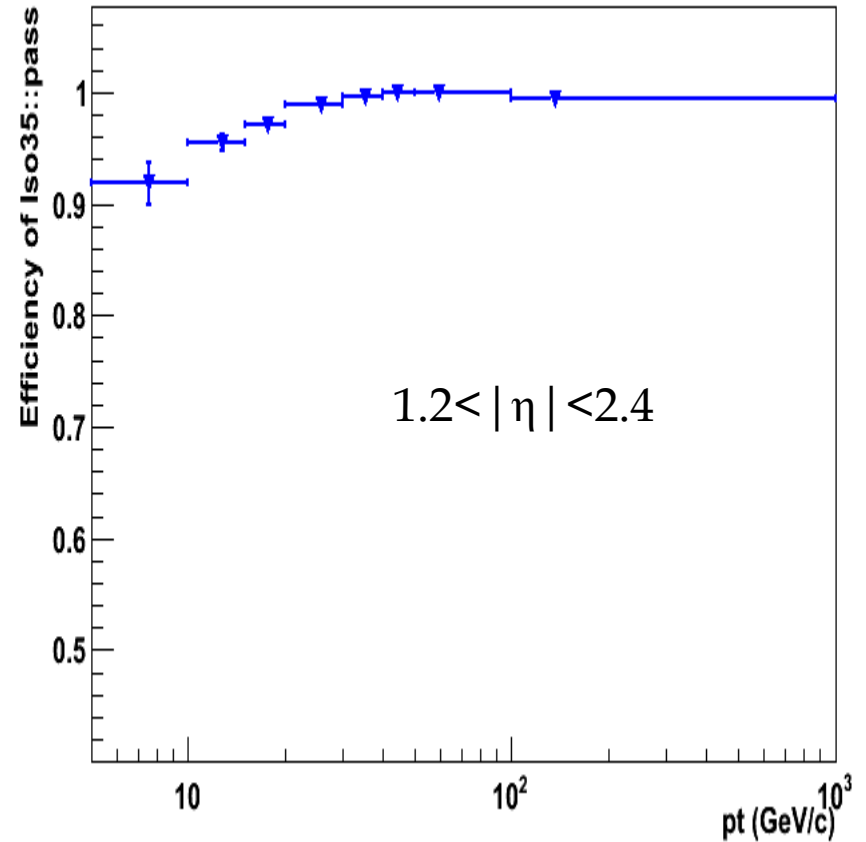
PT		$0 < \eta < 1.2$	$1.2 < \eta < 2.4$
5-10	Data	0.93 ± 0.05	0.92 ± 0.02
	MC	0.95 ± 0.04	0.92 ± 0.02
	Scale Factor	0.980 ± 0.067	1.000 ± 0.031
10 - 15	Data	0.93 ± 0.01	0.955 ± 0.008
	MC	0.92 ± 0.01	0.953 ± 0.009
	Scale Factor	1.010 ± 0.015	1.000 ± 0.013
10 – 20	Data	0.956 ± 0.006	0.971 ± 0.004
	MC	0.961 ± 0.006	0.974 ± 0.005
	Scale Factor	0.995 ± 0.0088	0.997 ± 0.0066
20 – 30	Data	0.983 ± 0.001	0.990 ± 0.001
	MC	0.983 ± 0.002	0.990 ± 0.001
	Scale Factor	1.000 ± 0.0023	1.000 ± 0.0014
PT		$0 < \eta < 1.2$	$1.2 < \eta < 2.4$
30 – 40	Data	0.9948 ± 0.0004	0.9961 ± 0.0005
	MC	0.9950 ± 0.0005	0.9946 ± 0.0007
	Scale Factor	0.9998 ± 0.00064	1.0015 ± 0.00087
40 - 50	Data	0.9987 ± 0.0002	0.9989 ± 0.0002
	MC	0.9991 ± 0.0002	0.9989 ± 0.0003
	Scale Factor	0.9996 ± 0.00028	1.0000 ± 0.00036
50 -100	Data	0.9986 ± 0.0003	0.9991 ± 0.0004
	MC	0.9981 ± 0.0005	0.9984 ± 0.0006
	Scale Factor	1.0005 ± 0.00058	1.0007 ± 0.00072
100 -1000	Data	0.995 ± 0.003	0.995 ± 0.004
	MC	0.998 ± 0.002	0.995 ± 0.005
	Scale Factor	0.997 ± 0.0036	1.000 ± 0.0064

Isolation efficiencies

Efficiency of Iso35::pass



Efficiency of Iso35::pass



Isolation efficiencies

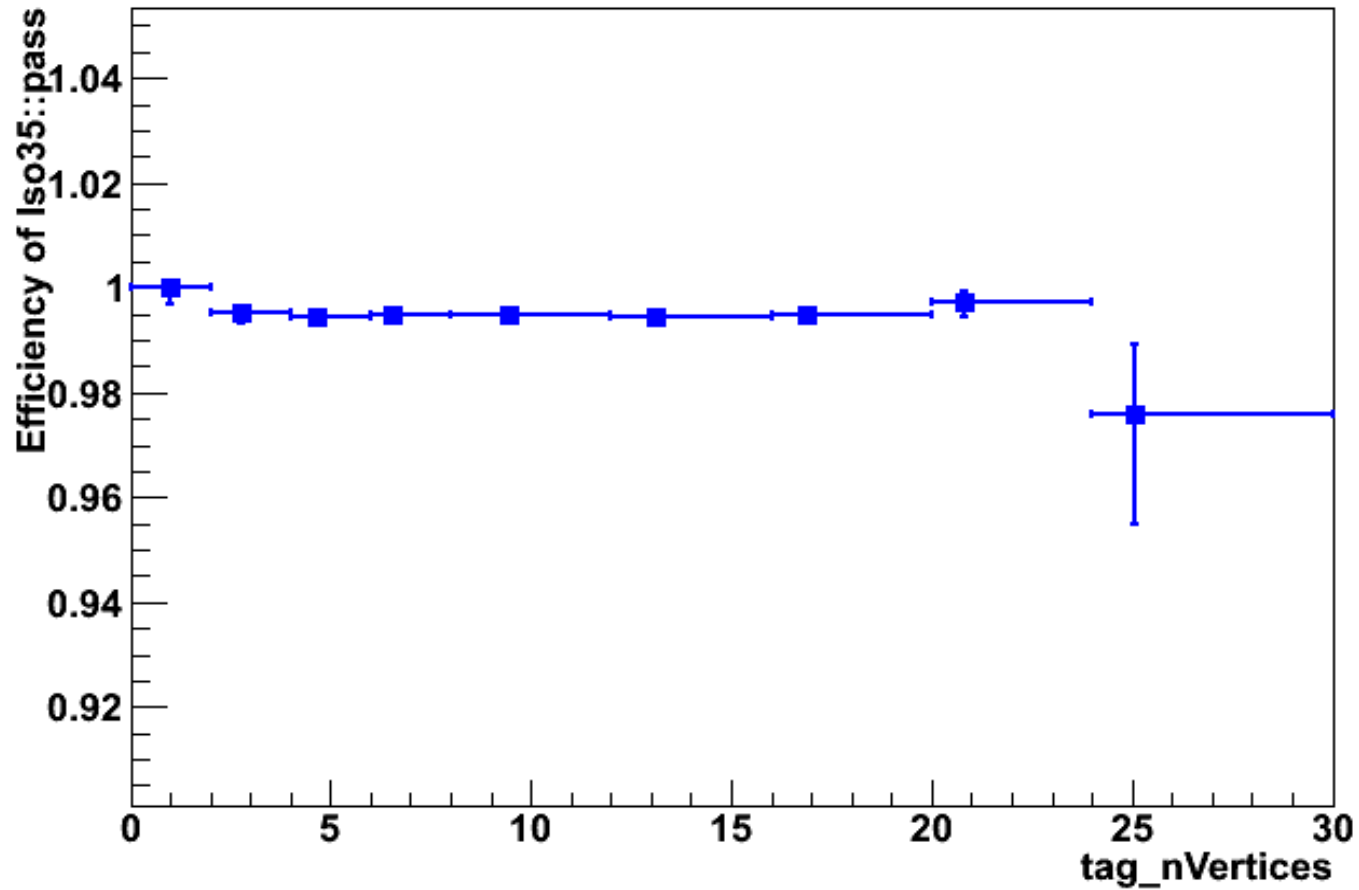
□ Particle-flow relative isolation in a $\Delta R = 0.3$ cone with delta Beta correction (PF Iso Tight < 0.35).

#vtx		Iso tight (PF in $\Delta R = 0.3$) < 0.35
0 - 2	Data	1.000±0.003
	MC	1.000±0.006
	Scale Factor	1.000 ± 0.0067
2 - 4	Data	0.995±0.002
	MC	0.993±0.002
	Scale Factor	1.002 ±0.0029
4 - 6	Data	0.9943±0.0008
	MC	0.9945±0.0010
	Scale Factor	1.000 ±0.0013
6 - 8	Data	0.9950±0.0005
	MC	0.9958±0.0006
	Scale Factor	0.9992 ±0.00078

8 - 12	Data	0.9949±0.0003
	MC	0.9945±0.0004
	Scale Factor	1.0004±0.00050
12 - 16	Data	0.9944±0.0005
	MC	0.9945±0.0005
	Scale Factor	0.9999±0.00071
16 - 20	Data	0.995±0.001
	MC	0.9965±0.0008
	Scale Factor	0.998 ±0.0013
20 - 24	Data	0.997±0.002
	MC	0.992±0.003
	Scale Factor	1.005 ±0.003
24 - 30	Data	0.98±0.02
	MC	0.998±0.003
	Scale Factor	0.98 ±0.020

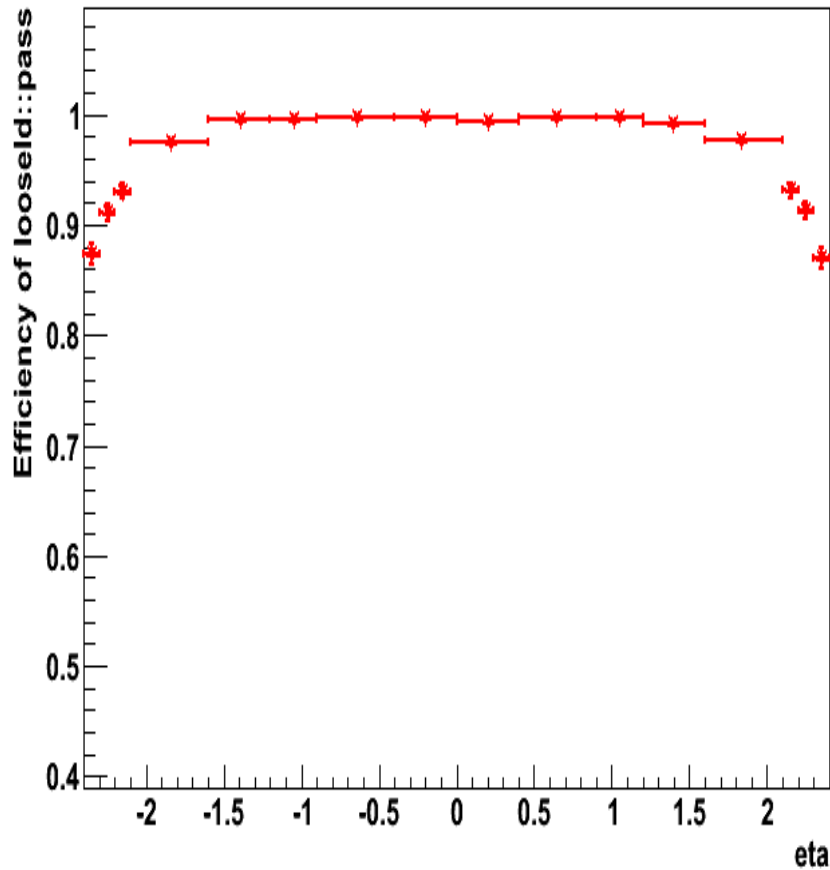
Isolation efficiencies

Efficiency of Iso35::pass

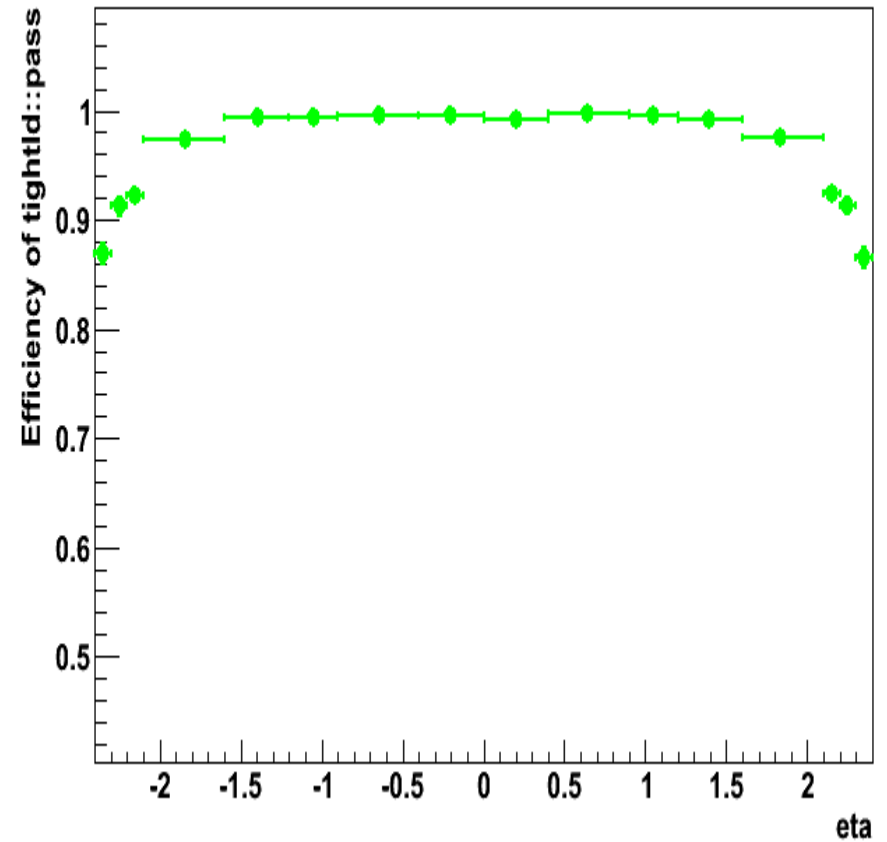


Muon Identification efficiency

Efficiency of looseld::pass

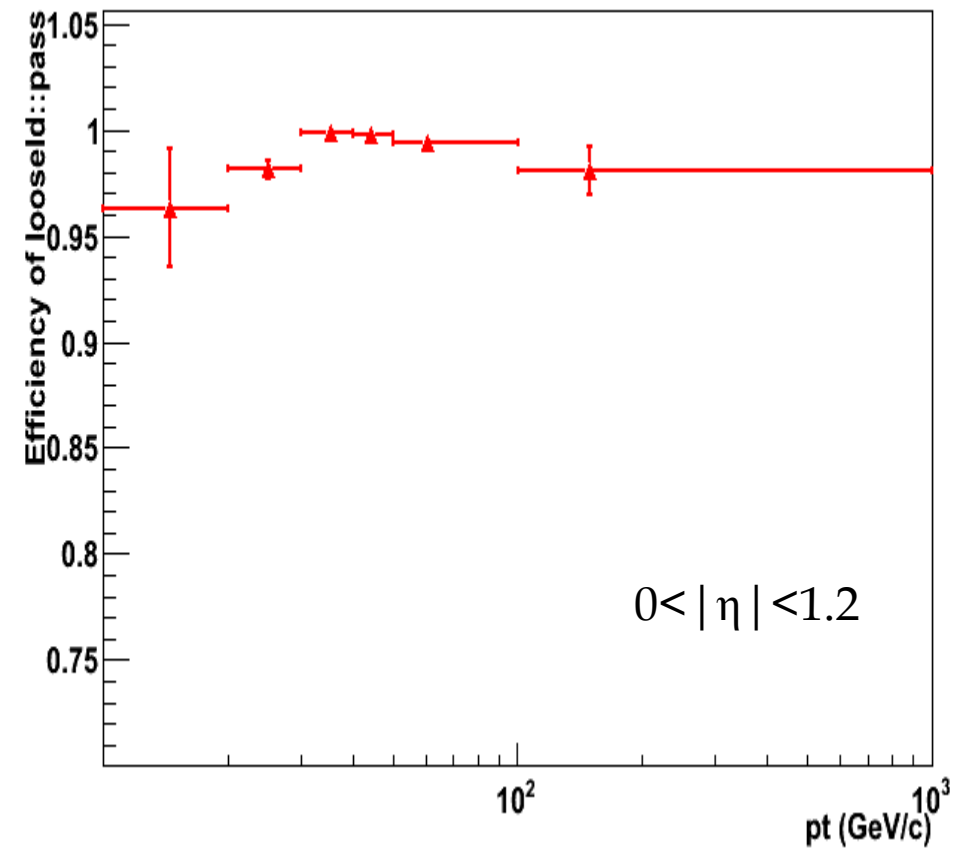


Efficiency of tightld::pass

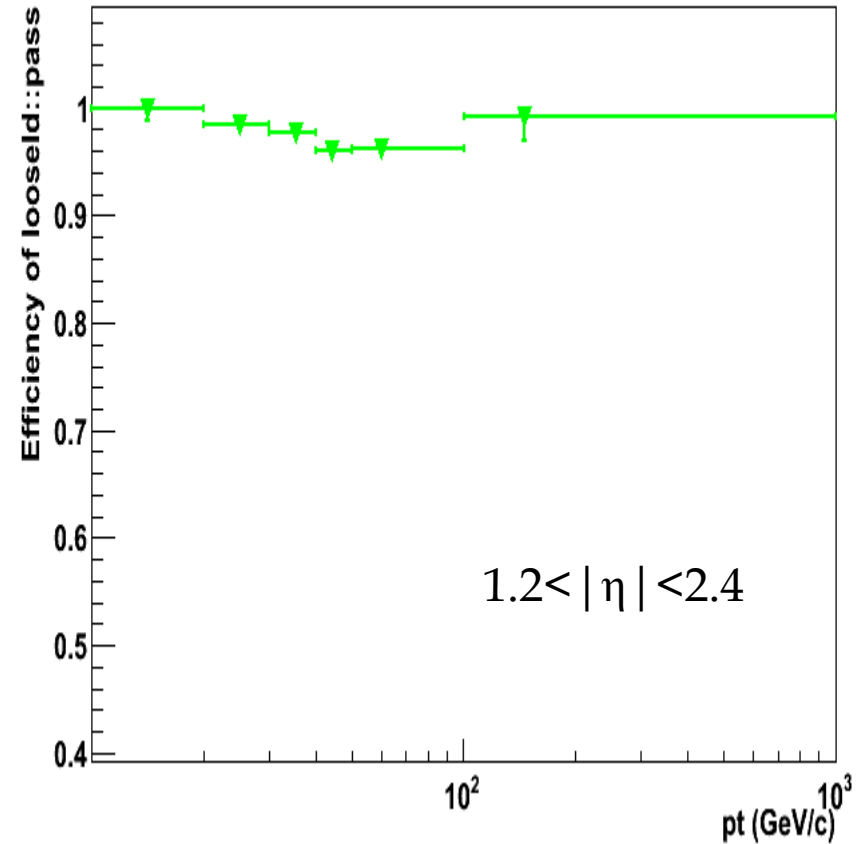


Muon Identification efficiency

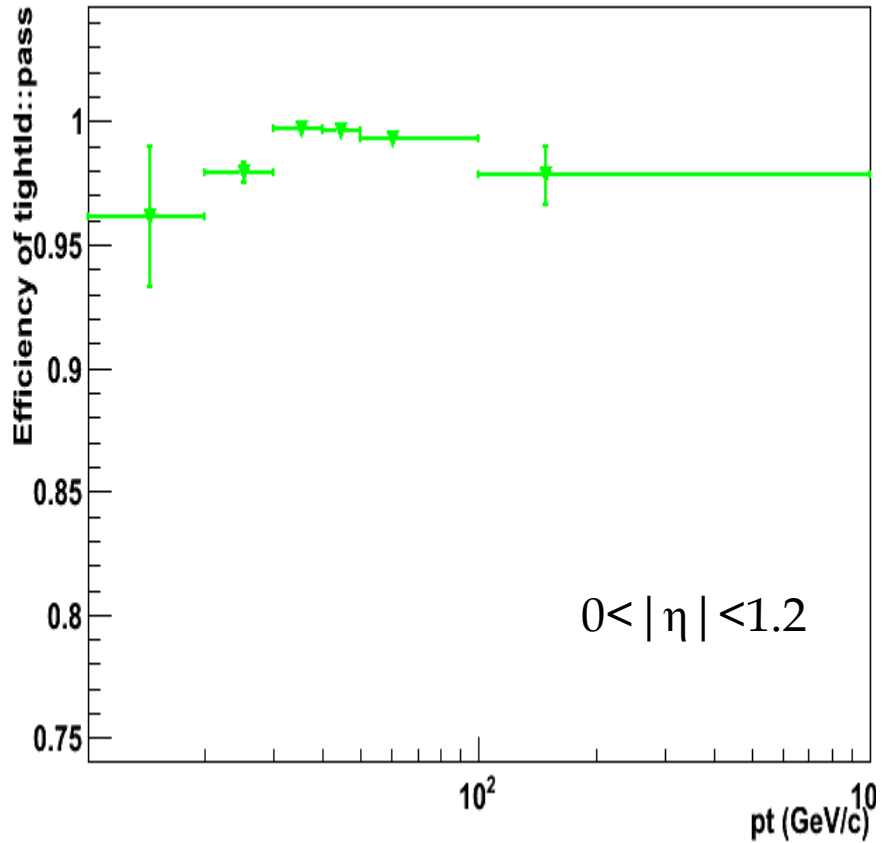
Efficiency of looseld::pass



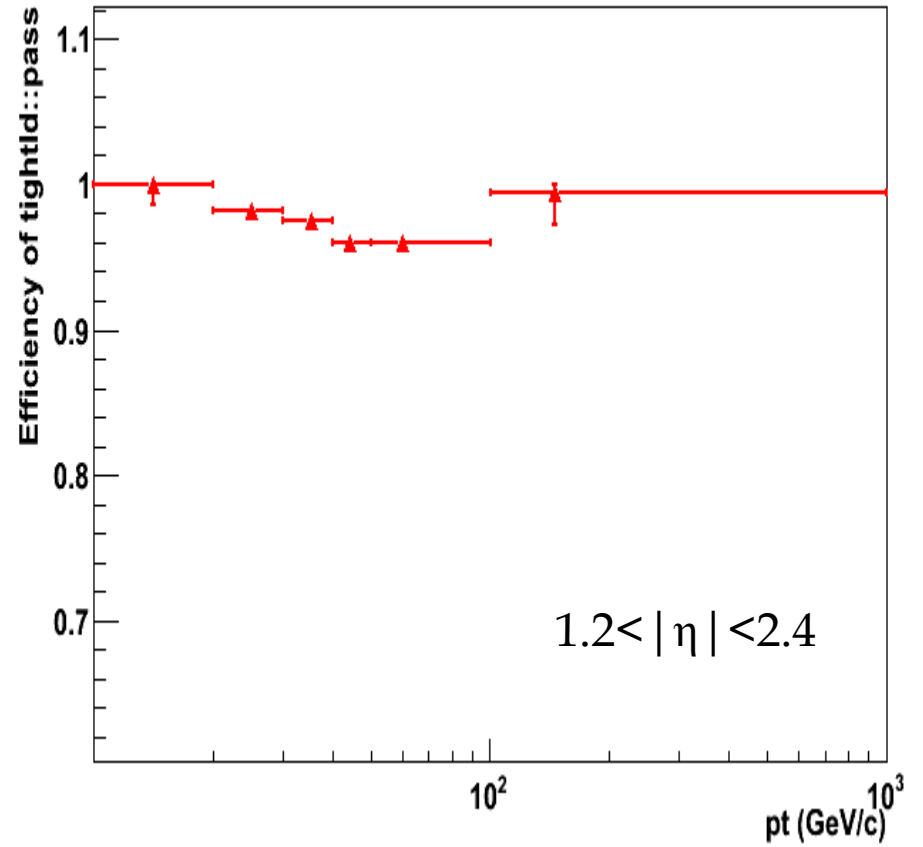
Efficiency of looseld::pass



Efficiency of tightld::pass



Efficiency of tightld::pass



Conclusion

Using the Tag and Probe (T&P) method performed on $Z \rightarrow \mu\mu$ events:

□ We measure the Muon efficiency for tight ID events in bins of p_T and $|\eta|$ for both Loose Muon ID & Tight Muon ID.

□ We measure the Muon efficiency of Particle-flow relative isolation in a $\Delta R = 0.3$ cone with delta Beta correction (**PF Iso Tight < 0.35**) in bins of p_T and $|\eta|$ and also in bins of #of vertices.